

**METHOD AND PROBE STRUCTURE FOR IMPLEMENTING A SINGLE
PROBE LOCATION FOR MULTIPLE SIGNALS**

Abstract of the Disclosure

- 5 A method and a probe structure are provided for implementing multiple signals probing of a printed circuit board. A probe structure is formed on an outside surface of the printed circuit board. A resistor is electrically connected with an associated via with a signal to be monitored. A path to a predefined probe location for monitoring the signal is defined from the resistor using the probe structure.